

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/990,558	CHOI ET AL.	
	Examiner	Art Unit	
	John L. Shew	2616	

# SEARCHED

Class	Subclass	Date	Examiner
370	320,329	7/28/2006	JS
	331		
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	338	8/1/2006	JS
	342,348	7/28/2006	
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455	432.1	7/28/2006	JS
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